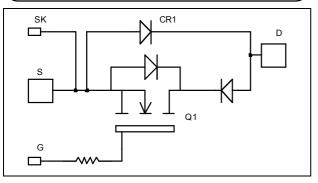
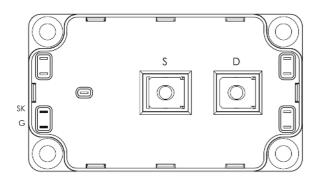


Single switch Series & parallel diodes MOSFET Power Module





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 $V_{DSS} = 200V$ $R_{DSon} = 4m\Omega \text{ typ } @ \text{ Tj} = 25^{\circ}\text{C}$ $I_D = 417\text{A} @ \text{Tc} = 25^{\circ}\text{C}$

Application

- Welding converters
 - Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- Power MOS 7[®] MOSFETs
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Avalanche energy rated
 - Very rugged
 - Kelvin source for easy drive
 - Very low stray inductance
 - Symmetrical design
 - M5 power connectors
 - High level of integration
 - AlN substrate for improved thermal performance

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V _{DSS}	Drain - Source Breakdown Voltage		200	V
т	Continuous Drain Current	$T_c = 25^{\circ}C$	417	
ID	I_D Continuous Drain Current $T_c =$		310	А
I _{DM}	Pulsed Drain current	1670		
V _{GS}	Gate - Source Voltage		± 30	V
R _{DSon}	Drain - Source ON Resistance		5	mΩ
PD	Maximum Power Dissipation $T_c = 25^{\circ}C$		1560	W
I _{AR}	Avalanche current (repetitive and non repetitive)		100	А
E _{AR}	Repetitive Avalanche Energy		50	mJ
E _{AS}	Single Pulse Avalanche Energy		3000	111)

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 200V$	$T_j = 25^{\circ}C$			500	۸
	Zero Gate voltage Drain Current	$V_{GS} = 0V, V_{DS} = 160V$ $T_j = 125^{\circ}C$			2000	μA	
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 208.5A$			4	5	mΩ
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 10 \text{mA}$		3		5	V
I _{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 30 V, V_{DS} = 0V$				±200	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C _{iss}	Input Capacitance	$V_{GS} = 0V$		28.8		
C _{oss}	Output Capacitance	$V_{\rm DS} = 25 V$		9.32		nF
C _{rss}	Reverse Transfer Capacitance	f = 1 MHz		0.58		
Qg	Total gate Charge	$V_{GS} = 10V$		560		
Q _{gs}	Gate – Source Charge	$V_{Bus} = 100V$		212		nC
Q_{gd}	Gate – Drain Charge	$I_{\rm D} = 417 {\rm A}$		268		
T _{d(on)}	Turn-on Delay Time	Inductive switching @ 125°C		32		
Tr	Rise Time	$V_{GS} = 15V$ $V_{GS} = 122V$		64		ns
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 133V$ $I_D = 417A$		88		
$T_{\rm f}$	Fall Time	$R_G = 1.2\Omega$		116		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		3396		I
$\mathrm{E}_{\mathrm{off}}$	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 133V$ $I_D = 417A, R_G = 1.2\Omega$		3716		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C		3744		т
$\mathrm{E}_{\mathrm{off}}$	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 133V I_D = 417A, R_G = 1.2\Omega$		3944		μJ

Series diode ratings and characteristics

Symbol	Characteristic 1	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			200			V
I _{RM}	Maximum Reverse Leakage Current	V _R =200V	$T_{j} = 25^{\circ}C$ $T_{i} = 125^{\circ}C$			1000 1250	μΑ
I _F	DC Forward Current		$T_c = 85^{\circ}C$		360		А
		$I_{\rm F} = 360 {\rm A}$		1.1	1.15	v	
$V_{\rm F}$	Diode Forward Voltage	$I_{\rm F} = 720 {\rm A}$			1.4		
		$I_{\rm F} = 360 {\rm A}$	$T_{j} = 125^{\circ}C$		0.9		
t _{rr}	Reverse Recovery Time		$T_j = 25^{\circ}C$		31		ns
ι _{rr}	Reverse Recovery Time	$I_{\rm F} = 360 {\rm A}$ $V_{\rm R} = 133 {\rm V}$	$T_{j} = 125^{\circ}C$		60		115
Q _{rr}	Powerse Posewary Charge	di/dt = 1000A	$v_{\rm R} = 135 v_{\rm J}$ di/dt = 1000A/µs $T_{\rm j} = 25^{\circ} {\rm C}$		360		nC
	Reverse Receivery charge		$T_{j} = 125^{\circ}C$		1500		ne



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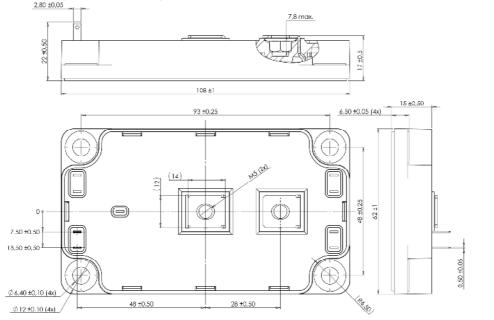
Parallel diode ratings and characteristics

Symbol	Characteristic 1	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			200			V
I _{RM}	Maximum Reverse Leakage Current	V _R =200V	$T_j = 25^{\circ}C$			1000	μA
I _F	DC Forward Current		$T_{j} = 125^{\circ}C$ $T_{c} = 85^{\circ}C$		360	1250	А
		$I_{\rm F} = 360 {\rm A}$	•		1.1	1.15	
$V_{\rm F}$	Diode Forward Voltage	$I_{\rm F} = 720 {\rm A}$			1.4		V
		$I_{\rm F} = 360 {\rm A}$	$T_{j} = 125^{\circ}C$		0.9		
t _{rr}	Reverse Recovery Time	$I_{-} = 360 \Lambda$	$T_j = 25^{\circ}C$		31		ns
ι _{rr}	Reverse Recovery Time		$T_j = 125^{\circ}C$		60		115
Qrr		$di/dt = 1000 A/\mu s$	$T_j = 25^{\circ}C$		360		nC
	Reverse Receivery charge		$T_{j} = 125^{\circ}C$		1500		пС

Thermal and package characteristics

Symbol	Characteristic				Min	Тур	Max	Unit
			Transistor Series Diode				0.08	
R _{thJC}	Junction to Case Thermal Resistance						0.12	°C/W
			Parallel D	iode			0.12	
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz				4000			V
T _J	Operating junction temperature range				-40		150	
T _{STG}	Storage Temperature Range				-40		125	°C
T _C	Operating Case Temperature						100	
Torque	To heatsi		nk M6	A6	3		5	N.m
Torque	Mounting torque	For terminals M5		А5	2		3.5	19.111
Wt	Package Weight						300	g

SP6 Package outline (dimensions in mm)

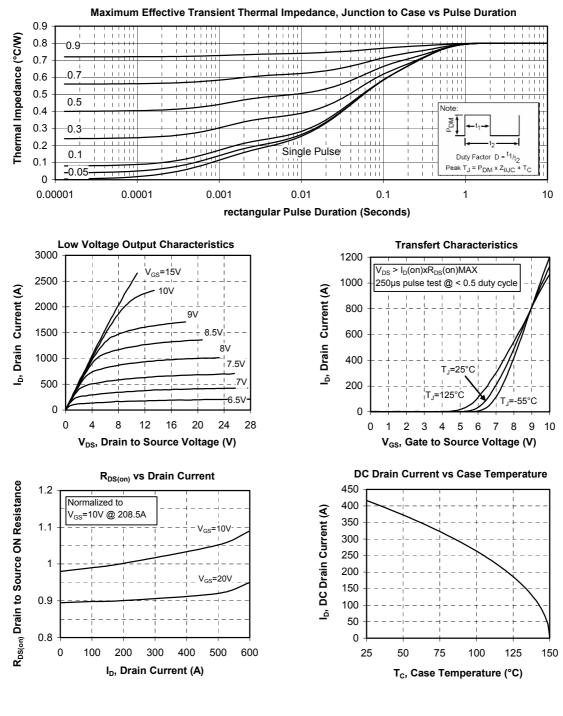


See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

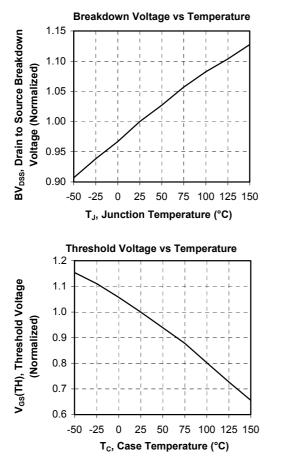
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Typical Performance Curve







Capacitance vs Drain to Source Voltage

Ciss

Coss

Crss

40

50

100000

10000

1000

100

0

10

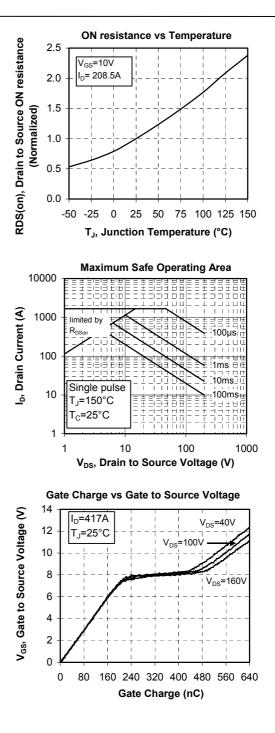
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V_{DS}, Drain to Source Voltage (V)

30

C, Capacitance (pF)

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500

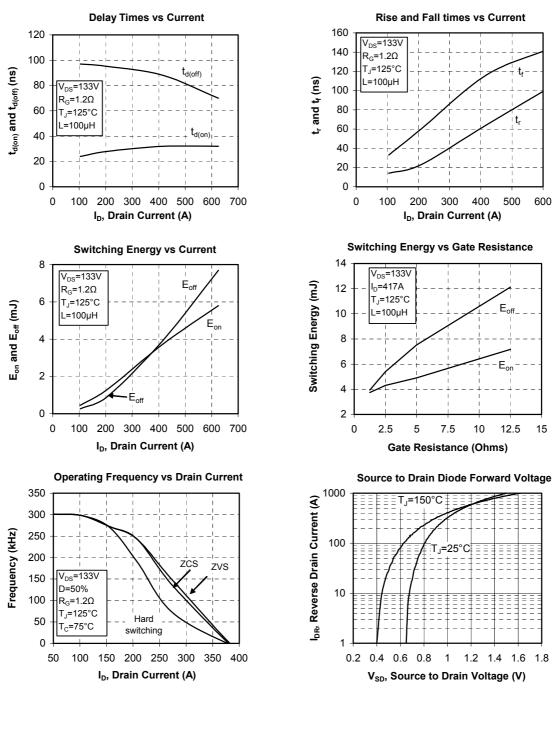
Eoff

12.5

1.6 1.8

15

600



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